

Notice of References Cited	Application/Control No. 10/820,325	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Nathan Wiehe	Art Unit 3745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,402,471	06-2002	Demers et al.	416/97R
	B	US-6,126,396	10-2000	Doughty et al.	416/97R
	C	US-5,246,340	09-1993	Winstanley et al.	416/97R
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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